

APR 10 1975

Meeting Date: March 10, 1975
Release Date: April 9, 1975

MEETING NOTES OF CTFA TALC SUBCOMMITTEE

PRESENT:

Dr. George Cohen	Bristol-Myers Products
Mr. Salvatore DiBianca	Mennen Co.
Mr. Raymond Krammes	Whittaker, Clark & Daniels
Mr. George Lee	Johnson & Johnson
Dr. R. Robert Rolle	Johnson & Johnson
Mr. George Sandland, Chairman	Bristol-Myers Products

COPY:

Dr. Tryggve Baak	Cyprus Industrial Minerals Co.
Dr. Murray Berdick	Chesebrough-Ponds, Inc.
Dr. Christopher Costello	Colgate-Palmolive Co.
Mr. Fred Roesch	Whittaker, Clark & Daniels
Dr. John Travers	Avon Products
Mr. Ronald Yakupcin	Kolmar Laboratories
Mr. Harold Stanley, Jr.	Pfizer
Dr. C. S. Thompson	R. T. Vanderbilt, Inc.
Dr. Allan M. Harvey	R. T. Vanderbilt, Inc.

CC: Members of Standard Committee

Ms. Anita Curry
Dr. Norman Estrin
Dr. John Menkart
Mr. Eugene Lambert

The meeting was held in the Bristol-Myers Technical Services Conference Room at Hillside.

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Sal DiBianca reported his results on 7 unknown samples of talc, which were analyzed for chrysotile by DTA. Positive readings were obtained on 2 of the samples, and 5 were negative. Dr. Rolle stated that the results are in agreement with the sample key codes.

Ray Krammes stated that de Bel and Richardson ran the same set of samples but that their results were inconclusive, since they did not follow the prescribed methodology.

George Sandland reported that Avon has submitted a list of analytical results on 315 talc samples from the U.S. and other countries around the world. Chesebrough has submitted a similar list of data on 36 samples of talc. All samples were negative for chrysotile. Pfizer, J & J and Cyprus are also submitting data.

Bob Rolle agreed to rewrite the X-ray diffraction method in the format of CTFA standards.

A discussion followed regarding the method of expressing a Fibrous Amphibole specification, and whether we should show "0.5% maximum" or "None detected" based on a method sensitivity of 0.5%. It was finally agreed that we set the specification at 0.5% maximum.

The 0.5% maximum specification was derived from the fact that many X-ray diffraction instruments in the industry are not capable of detecting less than this amount.

There being no further business, the meeting was adjourned.



G. W. Sandland
Chairman, CTFA Talc Subcommittee